# SYNCHRONOUS BURST SRAM

### 64K x 18 SRAM

+5V SUPPLY WITH CLOCKED, REGISTERED INPUTS, BURST COUNTER

#### **FEATURES**

- Fast access times: 8, 9, 10, and 12ns
- Fast clock speed: 83, 66, and 50 MHz
- Provide high performance 2-1-1-1 access rate
- Fast OE# access times: 5 and 6ns
- Single  $+5V \pm 5\%$  power supply
- 3.3V I/O compatible
- Clamp diodes to VSS at all inputs and outputs
- Common data inputs and data outputs
- Byte writeable via dual write enables
- · Address, data and control registers
- Internally self-timed WRITE CYCLE
- Automatic power-down for low power applications
- High board density 52-lead PLCC packages

OPTIONS	MARKING
• Timing	
8ns access/12ns cycle	-8
9ns access/15ns cycle	-9
10ns access/15ns cycle	-10
12ns access/20ns cycle	-12
<ul> <li>Packages</li> </ul>	
52-pin PLCC	C

#### **GENERAL DESCRIPTION**

The Galvantech Synchronous Burst SRAM family employs high-speed, low power CMOS designs using advanced double-layer polysilicon, double-layer metal technology. Each memory cell consists of four transistors and two high valued resistors.

The GVT7164B19 SRAM integrates 65,536 x18 SRAM cells with advanced synchronous peripheral circuitry and a 2-bit counter for internal burst operation. All synchronous inputs are gated by registers controlled by a positive-edge-triggered clock input (CLK). The synchronous inputs include all addresses, all data inputs, chip enable (CE#), burst control inputs (ADSC#, ADSP#, and ADV#), and write enables (WEL# and WEH#).

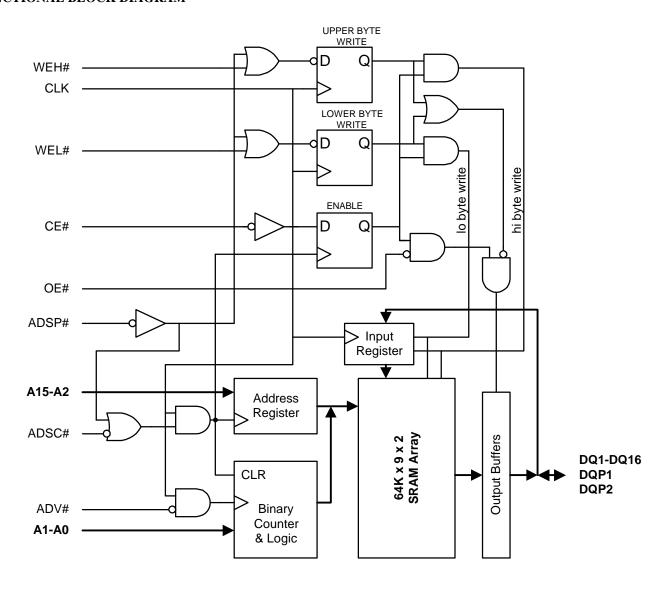
Asynchronous input includes the output enable (OE#). The data outputs (DQ), enabled by OE#, are also asynchronous.

Addresses and chip enables are registered with either address status processor (ADSP#) or address status controller (ADSC#) input pins. Subsequent burst addresses can be internally generated as controlled by the burst advance pin (ADV#).

Address, data inputs, and write controls are registered onchip to initiate self-timed WRITE cycle. WRITE cycles can be one or two bytes wide as controlled by the write control inputs. Individual byte enables allow individual bytes to be written. WEL# controls DQ1-DQ8 and DQP1. WEH# controls DQ9-DQ16 and DQP2.

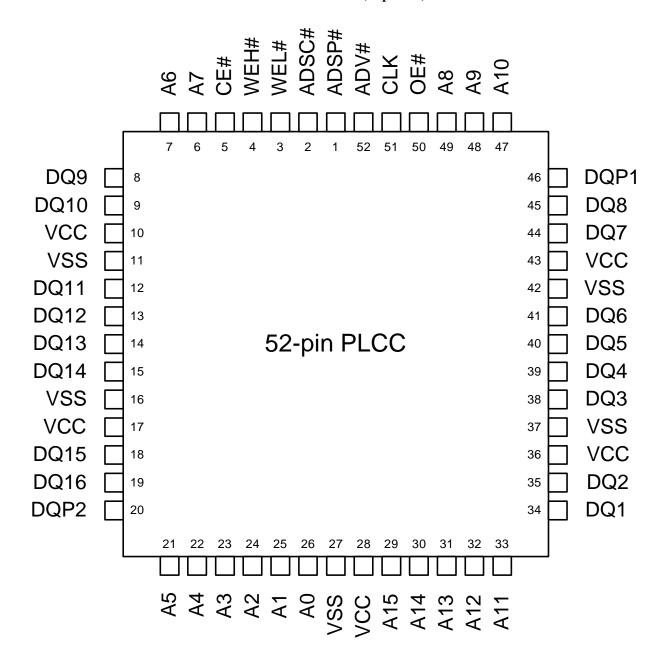
The GVT7164B19 operates from a +5V power supply. All inputs and outputs are TTL-compatible. The device is ideally suited for 486, Pentium<sup>TM</sup>, 680x0, and for systems that are benefited from a wide synchronous data bus.

#### FUNCTIONAL BLOCK DIAGRAM



**NOTE:** The Functional Block Diagram illustrates simplified device operation. See Truth Table, pin descriptions and timing diagrams for detailed information.

#### PIN ASSIGNMENT (Top View)



#### PIN DESCRIPTIONS

PLCC PINS	SYMBOL	TYPE	DESCRIPTION
26, 25, 24, 23, 22, 21, 7, 6, 49, 48, 47, 33, 32, 31, 30, 29	A0-A15	Input- Synchronous	Addresses: These inputs are registered and must meet the setup and hold times around the rising edge of CLK. The burst counter generates internal addresses associated with A0 and A1, during burst cycle and wait cycle.
3,4	WEL#, WEH#	Input- Synchronous	Byte Write Enables: A byte write enable is LOW for a WRITE cycle and HIGH for a READ cycle. WEL# controls DQ1-DQ8 and DQP1. WEH# controls DQ9-DQ16 and DQP2. Data I/O are high impedance if either of these inputs are LOW.
51	CLK	Input- Synchronous	Clock: This signal registers the addresses, data, chip enables, write control and burst control inputs on its rising edge. All synchronous inputs must meet setup and hold times around the clock's rising edge.
5	CE#	Input- Synchronous	Chip Enable: This active LOW input is used to enable the device.
50	OE#	Input	Output Enable: This active LOW asynchronous input enables the data output drivers.
52	ADV#	Input- Synchronous	Address Advance: This active LOW input is used to control the internal burst counter. A HIGH on this pin generates wait cycle (no address advance).
1	ADSP#	Input- Synchronous	Address Status Processor: This active LOW input causes a new external address to be registered and a READ cycle is initiated using the new address.
2	ADSC#	Input- Synchronous	Address Status Controller: This active LOW input causes device to be de-selected or selected along with new external address to be registered. A READ or WRITE cycle is initiated depending upon write control inputs.
34, 35, 38, 39, 40, 41, 44, 45, 8, 9, 12, 13, 14, 15, 18, 19	DQ1-DQ16	Input/ Output	Data Inputs/Outputs: Low Byte is DQ1-DQ8. HIgh Byte is DQ9-DQ16. Input data must meet setup and hold times around the rising edge of CLK.
46, 20	DQP1, DQP2	Input/ Output	Parity Inputs/Outputs: DQP1 is parity bit for DQ1-DQ8 and DQP2 is parity bit for DQ9-DQ16.
10, 17, 28, 36, 43	VCC	Supply	Supply: +5V ± 5%
11, 16, 27, 37, 42	VSS	Ground	Ground: GND

#### **BURST ADDRESS TABLE**

First Address (external)	Second Address (internal)	Third Address (internal)	Fourth Address (internal)
AA00	AA01	AA10	AA11
AA01	AA00	AA11	AA10
AA10	AA11	AA00	AA01
AA11	AA10	AA01	AA00

#### TRUTH TABLE

OPERATION	ADDRESS USED	CE#	ADSP#	ADSC#	ADV#	WRITE#	OE#	CLK	DQ
Deselected Cycle, Power Down	None	Н	Х	L	Х	Х	Х	L-H	High-Z
Deselected Cycle, Power Down	None	Н	L	Х	Χ	Х	Χ	L-H	High-Z
READ Cycle, Begin Burst	External	L	L	Х	Χ	Х	L	L-H	Q
READ Cycle, Begin Burst	External	L	L	Х	Χ	Х	Н	L-H	High-Z
WRITE Cycle, Begin Burst	External	L	Н	L	Χ	L	Χ	L-H	D
READ Cycle, Begin Burst	External	L	Н	L	Χ	Н	L	L-H	Q
READ Cycle, Begin Burst	External	L	Н	L	Χ	Н	Н	L-H	High-Z
READ Cycle, Continue Burst	Next	Х	Н	Н	L	Н	L	L-H	Q
READ Cycle, Continue Burst	Next	Х	Н	Н	L	Н	Н	L-H	High-Z
WRITE Cycle, Continue Burst	Next	Х	Н	Н	L	L	Х	L-H	D
READ Cycle, Suspend Burst	Current	Х	Н	Н	Н	Н	L	L-H	Q
READ Cycle, Suspend Burst	Current	Х	Н	Н	Н	Н	Н	L-H	High-Z
WRITE Cycle, Suspend Burst	Current	Χ	Н	Н	Н	L	Χ	L-H	D

Note:

- 1. X means "don't care." H means logic HIGH. L means logic LOW. WRITE# = L means WEL#\*WEH# equals LOW. WRITE# = H means WEL#\*WEH# equals HIGH.
- 2. WEL# enables write to DQ1-DQ8 and DQP1. WEH# enables write to DQ9-DQ16 and DQP2.
- 3. All inputs except OE# must meet setup and hold times around the rising edge (LOW to HIGH) of CLK.
- 4. Suspending burst generates wait cycle.
- 5. For a write operation following a read operation, OE# must be HIGH before the input data required setup time plus High-Z time for OE# and staying HIGH throughout the input data hold time.
- 6. This device contains circuitry that will ensure the outputs will be in High-Z during power-up.
- ADSP# LOW along with chip being selected always initiates an READ cycle at the L-H edge of CLK. A WRITE cycle can be
  performed by setting WRITE# LOW for the CLK L-H edge of the subsequent wait cycle. Refer to WRITE timing diagram for
  clarification.

#### PARTIAL TRUTH TABLE FOR READ/WRITE

FUNCTION	WEH#	WEL#	CE#	OE#
READ	Н	Н	L	L
WRITE high byte	L	Н	L	X
WRITE low byte	Н	L	L	Х
WRITE all bytes	L	L	L	Х

#### **ABSOLUTE MAXIMUM RATINGS\***

Voltage on VCC Supply Relative to	VSS0.5V to +7.0V
V <sub>IN</sub>	0.5V to VCC+0.5V
Storage Temperature (plastic)	
Junction Temperature	+125°
Power Dissipation	1.6W
Short Circuit Output Current	30mA

\*Stresses greater than those listed under "Absolute Maximum Ratings" may cause permanent damage to the device. This is a stress rating only and functional operation of the device at these or any other conditions above those indicated in the operational sections of this specification is not implied. Exposure to absolute maximum rating conditions for extended periods may affect reliability.

#### DC ELECTRICAL CHARACTERISTICS AND RECOMMENDED OPERATING CONDITIONS

 $(0^{\circ}\text{C} \le \text{T}_{\text{a}} \le 70^{\circ}\text{C}; \text{VCC} = 5\text{V} \pm 5\% \text{ unless otherwise noted})$ 

DESCRIPTION	CONDITIONS	SYMBOL	MIN	MAX	UNITS	NOTES
Input High (Logic 1) voltage		V <sub>IH</sub>	2.2	VCC+0.3	V	1,2
Input Low (Logic 0) Voltage		V <sub>II</sub>	-0.5	0.8	V	1, 2
Input Leakage Current	0V ≤ V <sub>IN</sub> ≤ VCC	IL <sub>I</sub>	-2	2	uA	
Output Leakage Current	Output(s) disabled, 0V ≤ V <sub>OUT</sub> ≤ VCC	ILO	-2	2	uA	
Output High Voltage	I <sub>OH</sub> = -4.0mA	V <sub>OH</sub>	2.4	3.3	V	1, 11
Output Low Voltage	I <sub>OL</sub> = 8.0mA	V <sub>OL</sub>		0.4	V	1, 11
Supply Voltage		VCC	4.75	5.25	V	1

DESCRIPTION	CONDITIONS	SYM	TYP	-8	-9	-10	-12	UNITS	NOTES
Power Supply Current: Operating	Device selected; all inputs $\leq V_{IL}$ or $\geq V_{IH}$ ; cycle time $\geq$ $^t$ KC MIN; VCC =MAX; outputs open	Icc	200	300	275	265	250	mA	3, 12, 13
CMOS Standby	Device deselected; VCC = MAX; all inputs ≤ VSS +0.2 or ≥VCC -0.2; all inputs static; CLK frequency = 0	I <sub>SB2</sub>	5	12	12	12	12	mA	12,13
TTL Standby	Device deselected; all inputs $\leq V_{IL}$ or $\geq V_{IH}$ ; all inputs static; VCC = MAX; CLK frequency = 0	I <sub>SB3</sub>	15	35	35	35	35	mA	12,13
Clock Running	Device deselected; all inputs $\leq$ V <sub>IL</sub> or $\geq$ V <sub>IH</sub> ; VCC = MAX; CLK cycle time $\geq$ <sup>t</sup> KC MIN	I <sub>SB4</sub>	30	60	50	50	40	mA	12,13

#### **CAPACITANCE**

DESCRIPTION	CONDITIONS	SYMBOL	TYP	MAX	UNITS	NOTES
Input Capacitance	$T_A = 25^{\circ}C$ ; f = 1 MHz	C <sub>I</sub>	4	5	pF	4
Input/Output Capacitance (DQ)	VCC = 5.0V	C <sub>O</sub>	6	8	pF	4

#### THERMAL CONSIDERATION

DESCRIPTION	CONDITIONS	SYMBOL	PLCC TYP	UNITS	NOTES
Thermal Resistance - Junction to Ambient	Still air, soldered on 4.25 x	$\Theta_{JA}$	TBD	°C/W	
Thermal Resistance - Junction to Case	1.125 inch 4-layer PCB	$\Theta_{\sf JC}$	3	°C/W	

#### AC ELECTRICAL CHARACTERISTICS

(Note 5) (0°C  $\leq$  T<sub>A</sub>  $\leq$  70°C; VCC = 5.0V  $\pm$ 5 %)

DECORIDATION		-	8	-	9	-1	10	-1	12		
DESCRIPTION	SYM	MIN	MAX	MIN	MAX	MIN	MAX	MIN	MAN	UNITS	NOTES
Clock											
Clock cycle time	<sup>t</sup> KC	12		15		15		20		ns	
Clock HIGH time	<sup>t</sup> KH	4		5		5		6		ns	
Clock LOW time	<sup>t</sup> KL	4		5		5		6		ns	
Output Times											
Clock to output valid	<sup>t</sup> KQ		8		9		10		12	ns	
Clock to output invalid	tKQX	3		3		3		3		ns	
Clock to output in Low-Z	<sup>t</sup> KQLZ	5		6		6		6		ns	6,7
Clock to output in High-Z	<sup>t</sup> KQHZ		5		5		5		6	ns	6,7
OE to output valid	<sup>t</sup> OEQ		5		5		5		6	ns	9
OE to output in Low-Z	<sup>t</sup> OELZ	0		0		0		0		ns	6,7
OE to output in High-Z	<sup>t</sup> OEHZ		5		5		5		6	ns	6,7
Setup Times	·						•				
Address, Controls and Data In	<sup>t</sup> S	2.5		2.5		2.5		3		ns	10
Hold Times											
Address, Controls and Data In	<sup>t</sup> H	0.5		0.5		0.5		0.5		ns	10

#### **CAPACITANCE DERATING**

DESCRIPTION	SYMBOL	ТҮР	MAX	UNITS	NOTES
Clock to output valid	$\Delta$ <sup>t</sup> KQ	0.016		ns / pF	14

#### AC TEST CONDITIONS

Input pulse levels	0V to 3.0V
Input rise and fall times	1.5ns
Input timing reference levels	1.5V
Output reference levels	1.5V
Output load	See Figures 1 and 2

#### **OUTPUT LOADS**

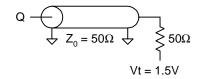


Fig. 1 OUTPUT LOAD EQUIVALENT

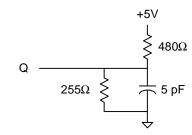


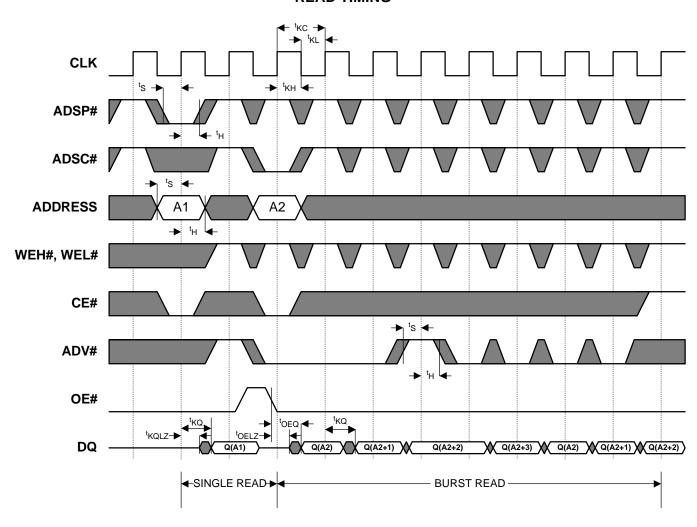
Fig. 2 OUTPUT LOAD EQUIVALENT

#### **NOTES**

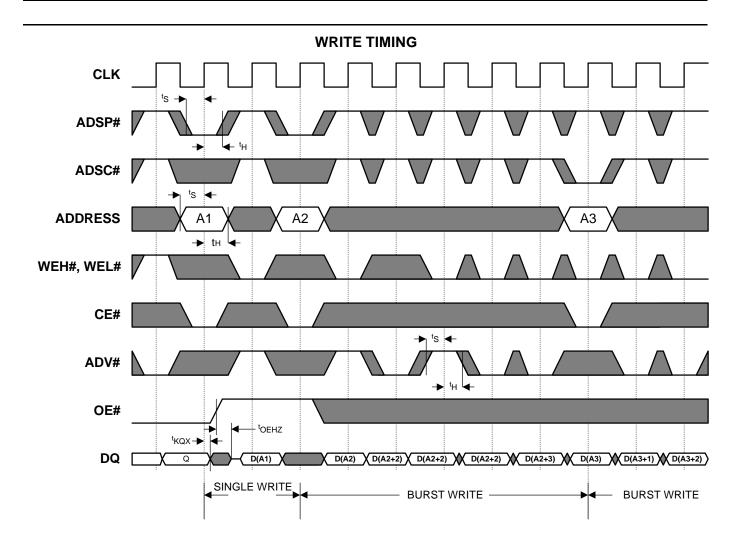
- 1. All voltages referenced to VSS (GND).
- 2. Overshoot:  $V_{IH} \le +6.0V$  for  $t \le {}^{t}KC$  /2. Undershoot:  $V_{IL} \le -2.0V$  for  $t \le {}^{t}KC$  /2
- 3.  $I_{cc}$  is given with no output current.  $I_{cc}$  increases with greater output loading and faster cycle times.
- 4. This parameter is sampled.
- Test conditions as specified with the output loading as shown in Fig. 1 unless otherwise noted.
- 6. Output loading is specified with CL=5pF as in Fig. 2.
- At any given temperature and voltage condition, <sup>t</sup>KQHZ is less than <sup>t</sup>KOLZ and <sup>t</sup>OEHZ is less than <sup>t</sup>OELZ.
- A READ cycle is defined by byte write enables all HIGH or ADSP# LOW along with chip enables being active for the required setup and hold times. A WRITE cycle is defined by at one byte or all byte WRITE per READ/WRITE TRUTH TABLE
- 9. OE# is a "don't care" when a byte write enable is sampled LOW.
- 10. This is a synchronous device. All synchronous inputs must meet specified setup and hold time, except for "don't care" as defined in the truth table.
- 11. AC I/O curves are available upon request.
- 12. "Device Deselected" means the device is in POWER -DOWN mode as defined in the truth table. "Device Selected" means the device is active.
- 13. Typical values are measured at 5.0V, 25°C and 20ns cycle time.
- 14. Capacitance derating applies to capacitance different from the load capacitance shown in Fig. 1.

### GVT7164B19 64K X 18 SYNCHRONOUS BURST SRAM

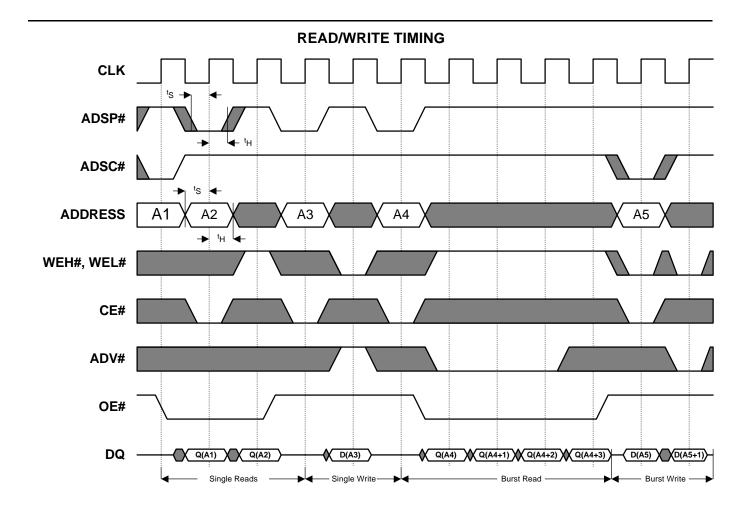
#### **READ TIMING**



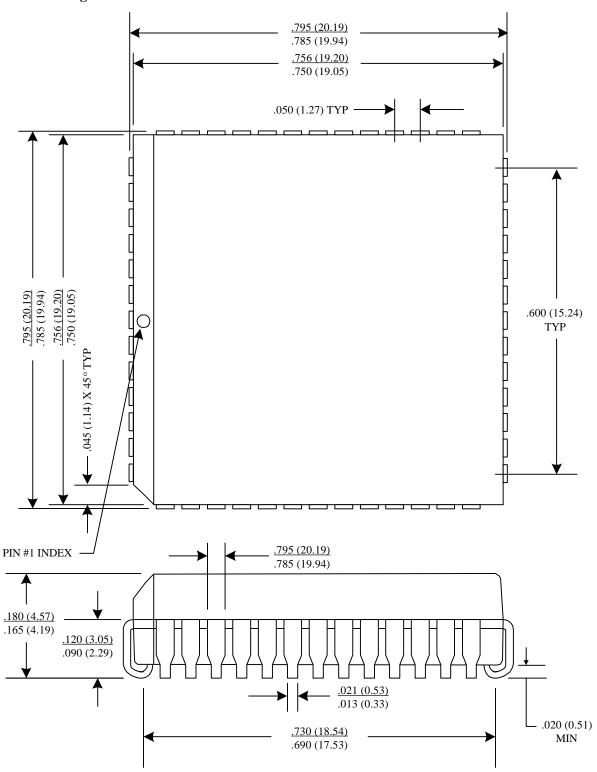
### GVT7164B19 64K X 18 SYNCHRONOUS BURST SRAM



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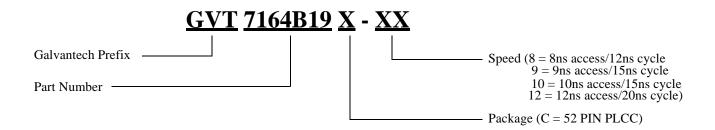
#### **52 Pin PLCC Package Dimensions**



Note: All dimensions in inches (millimeters)

AX or typical where noted.

## **Ordering Information**



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